

Search Notes**Application/Control No.**

09/782,306

Examiner

Devesh Khare

Applicant(s)/Patent under Reexamination

WENZEL ET AL.

Art Unit

1623

SEARCHED

Class	Subclass	Date	Examiner
514	567,28 300,415 564,406		
	255-05		
	256, 183,242		
	275,314, 333,340		
	365,381		
	640,258		
516	238, 405, 333,371		
424	195-1		
536	4-1,8	9/15/06	dk.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC Search STN Search - Anna Jiang	7/16/05 6/10/06	dk aw
East Search	12/23/06	dk
	9/15/06	dk

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner